# International Rectifier

## POWER MOSFET SURFACE MOUNT(SMD-1)

**Product Summary** 

Part Number	RDS(on)	ID		
IRFN450	0.415 Ω	12A		

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

## IRFN450 JANTX2N7228U JANTXV2N7228U REF:MIL-PRF-19500/592 500V, N-CHANNEL

**HEXFET® MOSFETTECHNOLOGY** 



#### Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Surface Mount
- Dynamic dv/dt Rating
- Light-weight

### **Absolute Maximum Ratings**

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	12	
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	8.0	Α
IDM	Pulsed Drain Current ①	48	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Max. Power Dissipation	150	W
	Linear Derating Factor	1.2	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	750	mJ
IAR	Avalanche Current ①	12	Α
EAR	Repetitive Avalanche Energy ①	15	mJ
dv/dt	Peak Diode Recovery dv/dt 3	3.5	V/ns
TJ	Operating Junction	-55 to 150	
TSTG Storage Temperature Range			°C
	Package Mounting Surface Temperature	300(for 5 seconds)	
	Weight	2.6 (Typical)	g

For footnotes refer to the last page

## Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

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	Parameter	Min	Тур	Max	Units	Test Conditions	
BVDSS	Drain-to-Source Breakdown Voltage	500	_	_	V	VGS = 0V, ID = 1.0mA	
ΔBVDSS/ΔTJ	Temperature Coefficient of Breakdown Voltage	_	0.68	_	V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA	
RDS(on)	Static Drain-to-Source On-State	_	_	0.415	Ω	VGS = 10V, ID = 8.0A (4)	
	Resistance	_	_	0.515	32	VGS = 10V, ID = 12A	
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	
9fs	Forward Transconductance	6.5	_	_	S (7)	V <sub>DS</sub> > 15V, I <sub>DS</sub> = 8.0A ④	
IDSS	Zero Gate Voltage Drain Current		_	25	μА	V <sub>DS</sub> = 400V ,V <sub>GS</sub> =0V	
		_	_	250	μΑ	V <sub>DS</sub> = 400V,	
						VGS = 0V, TJ = 125°C	
IGSS	Gate-to-Source Leakage Forward	_	_	100	nA	VGS = 20V	
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	nA	VGS = -20V	
Qg	Total Gate Charge	_	_	120		VGS =10V, ID = 12A	
Qgs	Gate-to-Source Charge	_	_	19	nC	V <sub>DS</sub> =250V	
Q <sub>gd</sub>	Gate-to-Drain ('Miller') Charge	_	_	70			
<sup>t</sup> d(on)	Turn-On Delay Time	_	_	35		$V_{DD} = 250V, I_{D} = 12A,$	
tr	Rise Time	_	_	190	ns	$V_{GS} = 10V, R_{G} = 2.35\Omega$	
<sup>t</sup> d(off)	Turn-Off Delay Time	_	_	170	115		
tf	Fall Time	_	_	130			
Ls+LD	Total Inductance	_	4.0	_	nΗ	Measured from the center of drain	
						pad to center of source pad.	
Ciss	Input Capacitance		2700			$V_{GS} = 0V, V_{DS} = 25V$	
Coss	Output Capacitance	_	600	_	pF	f = 1.0MHz	
C <sub>rss</sub>	Reverse Transfer Capacitance	_	240	_			

## **Source-Drain Diode Ratings and Characteristics**

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Continuous Source Current (I	Body Diode)	_	_	12		
ISM	Pulse Source Current (Body I	Diode) ①	_	_	48	Α	
VSD	Diode Forward Voltage		_	_	1.7	V	$T_j = 25$ °C, $I_S = 12A$ , $V_{GS} = 0V$ ④
t <sub>rr</sub>	Reverse Recovery Time		_	_	1600	nS	$T_j$ = 25°C, $I_F$ = 12A, $di/dt$ ≤ 100A/μs
QRR	Reverse Recovery Charge		_	_	14	μC	V <sub>DD</sub> ≤ 30V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L <sub>S</sub> + L <sub>D</sub> .					

## **Thermal Resistance**

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	_	_	0.83	°C/W	
R <sub>th</sub> J-PCB	Junction-to-PC board	_	3.0	_	C/VV	Soldered to a copper-clad PC board

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

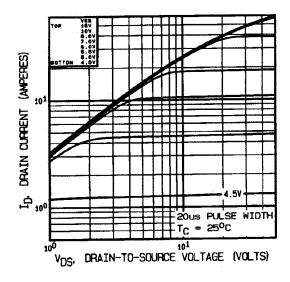


Fig 1. Typical Output Characteristics

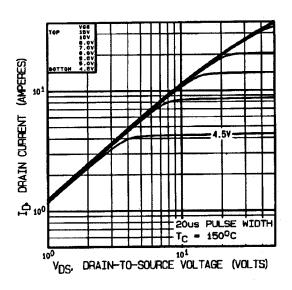


Fig 2. Typical Output Characteristics

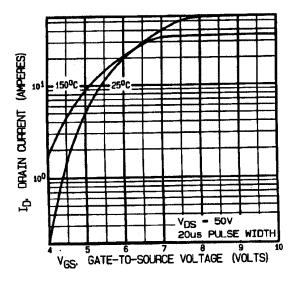
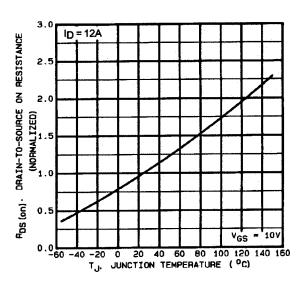
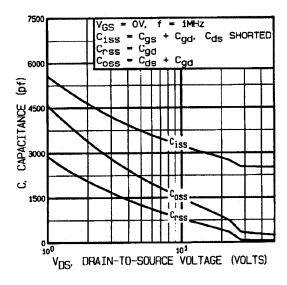


Fig 3. Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature



1D = 12A

V<sub>DS</sub> - 400V

V<sub>DS</sub> = 250V

V<sub>DS</sub> - 100V

12

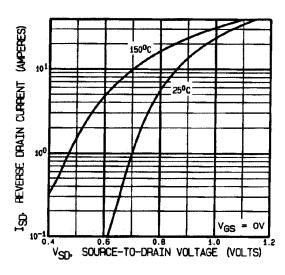
FOR TEST CIRCUIT

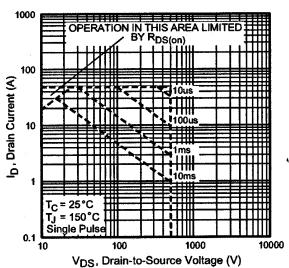
SEE FIGURE 13a & b

Q<sub>g</sub>. TOTAL GATE CHARGE (nC)

**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

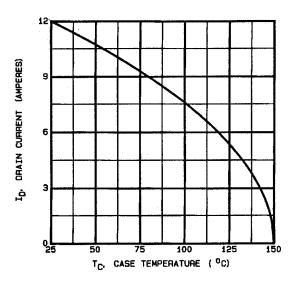
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage





**Fig 7.** Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature

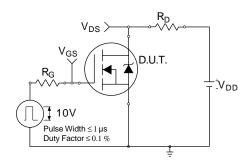


Fig 10a. Switching Time Test Circuit

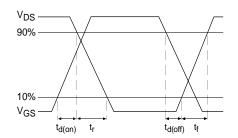


Fig 10b. Switching Time Waveforms

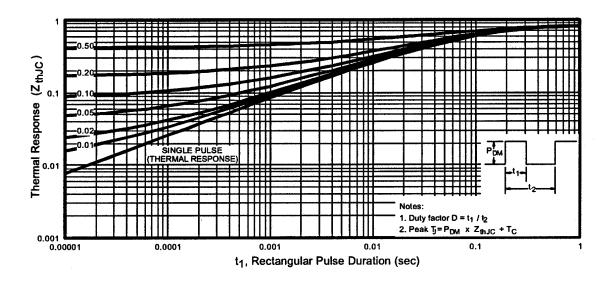


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

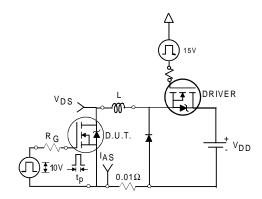


Fig 12a. Unclamped Inductive Test Circuit

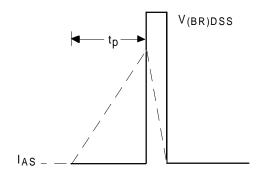


Fig 12b. Unclamped Inductive Waveforms

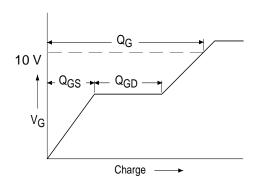
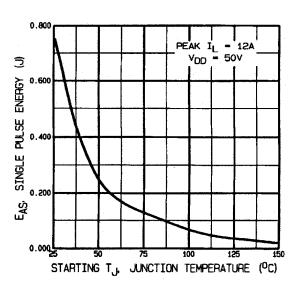


Fig 13a. Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

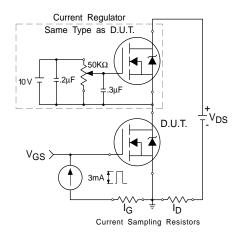


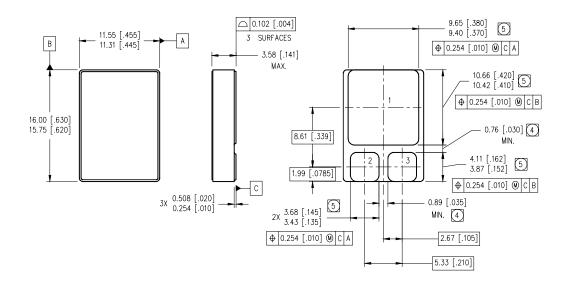
Fig 13b. Gate Charge Test Circuit

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#### Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② VDD = 25V, starting TJ = 25°C, L= 10.4mH Peak I<sub>L</sub> = 12A, V<sub>G</sub>S = 10V
- ③ ISD ≤ 12A, di/dt ≤ 130A/ $\mu$ s,  $V_{DD} \le 500V$ ,  $T_{J} \le 150$ °C
- 4 Pulse width  $\leq 300 \ \mu s$ ; Duty Cycle  $\leq 2\%$

#### Case Outline and Dimensions — SMD-1



#### NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- DIMENSION INCLUDES METALLIZATION FLASH.
- DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

#### PAD ASSIGNMENTS

- 1- DRAIN
- 2- GATE
- 3- SOURCE



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